Oxidation Prevention and Electrical Property Enhancement of Copper-Filled Isotropically Conductive Adhesives

MYUNG JIN YIM,¹ YI LI,¹ KYOUNG SIK MOON,¹ and C.P. WONG^{1,2}

1.—School of Materials Science and Engineering, Georgia Institute of Technology, 771 Ferst Drive, Atlanta, GA 30332, USA. 2.—e-mail: cp.wong@mse.gatech.edu

This paper describes the development and characterization of isotropically conductive adhesives (ICAs) incorporating copper (Cu) powders as electrically conductive fillers, along with a silane coupling agent for oxidation protection of copper powders, for environmentally friendly, low cost and high thermal reliability applications in microelectronics packaging. The effect of silane coupling agent materials and concentration on the electrical conductivity, thermal stability and reliability of Cu-filled ICAs was investigated for potential alternatives of conventional silver-filled ICAs. The surface characteristics of silane thin films on copper surfaces, such as their hydrophobicity and thermal stability, were also evaluated to compare the performance of antioxidant behaviors of different silane coupling agents for Cu-filled ICAs. The low contact resistance and high thermal stability of the contact resistance of Cu-filled ICAs were achieved by addition of an optimized silane coupling agent. Greater thermal stability and improved reliability of Cu-filled ICAs under high temperature and humidity conditions were achieved with a silane coupling agent of high molecular weight and hydrophobicity. The bulk resistivity of $\sim 10^{-4}$ Ωcm of Cu-filled ICAs was achieved with bimodal filler loading.

Key words: Isotropic conductive adhesive (ICA), copper, antioxidant, silane coupling agent, electrical contact resistance, reliability

INTRODUCTION

Isotropically conductive adhesives (ICAs) are being used to replace the traditional eutectic SnPb and Pb-free solder alloys in electronic packaging and interconnections.^{1,2} They are composites of polymer resin and conductive fillers. The polymer resins and thermoplastic or thermosetting resins, generally cured at high temperature, are used as ICA matrix resin and provide the shrinkage force and adhesion strength, and good chemical and corrosion strength. Epoxy, cyanate ester, silicone, and polyurethane are typical thermosetting resins, and phenolic epoxy and polyimide are common thermoplastics, for ICA matrix resin. Conductive fillers include silver (Ag), gold (Au), nickel (Ni), copper (Cu) and tin (Sn), tin-bismuth (SnBi) or tin-indium

(SnIn) coated Cu in various sizes and shapes. Ag is the most common conductive fillers for ICA, due to its high conductivity and easy processing, but its high cost is one of the drawbacks for wide use of Ag-filled ICAs. ICAs have been used for die attach adhesives,³ adhesives in surface mount technology (SMT),^{4,5} and flip chip⁶ and other applications. Figure 1 shows the schematics of SMT and flip chip components assembled by ICA joints instead of solder joints. However, current ICAs still have some limitations in terms of their electrical, thermal, and reliability properties, compared with those of lead or lead-free solders, for solder replacement purpose.

Therefore, many research efforts have been focused mainly on the improvement of electrical conductivity and reliability performance of ICA joints. Also, the replacement of expensive Ag flakes by new metal flakes has been pursued for the wide use of ICAs instead of solder materials. Copper can be a promising candidate for conductive filler metal, due to its low resistivity, low cost and improved

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Fig. 1. Schematic structures of (a) surface mount interconnection using ICA, and (b) flip chip interconnection using ICA.

electro-migration performance, but oxidation causes this metal to lose its conductivity.⁷

There are, basically, two approaches to surface treatment on copper fillers for ICA application. One is inorganic material coating, and the other is organic material coating. For inorganic coating materials, silver, gold and nickel/gold and solder materials, such as Sn and InSn, are some examples which are coated by electro- or electroless deposition.⁸ For organic coating materials on copper surfaces for oxidation/corrosion protection, self-assembly monolayer (SAM) formation, such as azole or thiol compounds,^{9,10} and organosilicic compound formation¹¹ are the representatives; however, their poor thermal stabilities are concerns, because most of the coatings lose their effectiveness when exposed to the curing condition of ICAs.

For self-assembly monolayer formation, dodecanethiol (DT), mercaptobenzothiazole (MBT), benzotriazole (BTA), imidazole (IMD), or benzothiazole (BT) can be formed on the surface of copper films,⁹ but they are not useful, due to low thermal stability for the coating layer on the copper filler in ICAs, which is normally cured at 150°C for 30–60 min. Also SAM layer of hexadecanethiol (HDT) on oxidized and clean copper surfaces¹⁰ can be formed, but its poor thermal stability above 150°C is one drawback for an organic protection layer on copper fillers in electrically conductive adhesives (ECAs). For organosilicic compound formation, methyltriethoxysilane (MTES)¹¹ is used to maintain the luster and high electric conductivity and to prevent the oxidation of copper metal, but this silane is not effective in preventing Cu oxidation at the cure condition of a typical ICA formulation.

In this study, we developed and characterized the Cu-filled ICAs by using novel silane coupling agents for oxidation prevention of Cu fillers for conventional ICA applications. The effect of the materials and concentrations of silane coupling agents on the electrical conductivity, high thermal stability, and reliability of Cu-filled ICAs was investigated for potential alternatives of conventional silver-filled ICAs. We also evaluated the surface characteristics of silane thin films on copper surfaces, such as their

hydrophobicity and thermal stability, to compare the antioxidant behaviors of different silane coupling agents in Cu-filled ICAs.

EXPERIMENTS

Preparation of Materials

We formulated the Cu-filled ICA by the *in situ* mixing of silane coupling agent with Cu powder by the following procedure: The copper powders were dipped in 10% HNO₃ solution, to remove native oxide layers on the surfaces of the Cu powders, and washed with deionized (DI) water and methanol, twice, and then dried at room temperature under a nitrogen atmosphere.

For the ICA formulation, we used a mixture of liquid epoxy resin, anhydride hardener, and imidazole catalyst for the polymer matrix system and added Cu powders up to 80 wt.%. Two silane coupling agents were added to the ICA formulation, with variation of concentrations and types. The first coupling agent (CA 1) had an aliphatic structure, and the second (CA 2) had an aromatic structure.

The Cu-filled ICAs were cured at 150°C for 60 min on a digital hot plate and in a convection oven. For the bimodal filler loading of Cu fillers in the ICA formulation, we prepared Cu powders, which were composed of particles with 30–40 μm diameters, and followed the same procedure as for the acid treatment. We rinsed them to obtain oxide-free Cu powders and formulated ICA composite with Cu powders of 1–5 μm diameter (40 wt.%) and 30–40 μm diameter (40 wt.%), respectively. The bulk resistivity of the Cu-filled ICA in bimodal filler loading with optimized silane coupling agents was measured after the thermal curing process.

Scanning electron microscopy (SEM) was used for the cross-sectional view of Cu-filled ICA, using a Hitachi S-800 FE-SEM.

Electrical Conductivity and Reliability Test

The effect of the silane coupling agents on the electrical conductivity of Cu-filled ICA composite was characterized by the *in situ* measurement of the electrical contact resistance during the curing of Cu-filled ICA. The effect of the content of the silane coupling agents on the thermal stability of the electrical contact resistance of cured Cu-filled ICA was evaluated by the monitoring of the contact resistance of Cu-filled ICA with increasing temperature up to 270°C. The thermal stability of the electrical contact resistance of Cu-filled ICA with different silane coupling agents during a multiple reflow process was also evaluated. The bulk resistivities of Cu-filled ICA materials with different silane coupling agents in optimized concentrations were measured. The schematics of contact resistance and bulk resistivity measurement of Cu-filled ICAs are shown in Fig. 2.

The bulk resistivities and the reliabilities of Cu-filled ICAs with different silane coupling agents

Fig. 2. Schematic drawings of (a) contact resistance and (b) bulk resistance measurements of Cu-filled ICAs.

were assessed by the bulk resistivity behaviors of Cu-filled ICAs under conditions of high temperature/humidity and high temperature/dryness for 24 h. The Cu-filled ICAs with bimodal distribution of Cu fillers with optimized silane coupling agent was finally prepared, and its bulk resistivity was measured.

Contact Angle Measurement

To prove the hydrophobicity of the silane coating layer on the Cu surface, we investigated the contact angle behavior of the silane coating layer on the surface of a Cu plate. A thin copper plate was cut into approximately 1 cm² pieces with a low speed saw. We prepared 5 wt.% and 10 wt.% of CA 1 and CA 2 ethanol solutions and used them to treat the copper plates, respectively. The immersion time of copper in a silane solution was 10, 30, or 50 min. After being treated in the silane solution, the copper was cured in the oven at 130°C for 30 min, as indicated in Table I.

We measured the contact angle at three locations on each sample surface by dropping deionized (DI) water onto the plate using an automatic pipette and the computer system of a goniometer (Rame-Hart Co.). The ten measurements at the three locations were all averaged to provide a mean contact angle for that sample. Two of the combinations of dipping time and curing temperature were recreated for each silane solution so that the effect of aging on the contact angle could be tested. The samples were dipped for 30 min in the silane solution and cured at 130°C for 30 min. Untreated samples were also prepared as before. All of the samples, as shown in

Table II, were aged at 50, 100, 150, or 200°C for 10 min in the oven before being tested.

RESULTS AND DISCUSSION

Effect of Coupling Agent on Electrical Contact Resistance of Cu-Filled ICAs During the Cure Process

Figure 3 shows the change in contact resistance for two uncured Cu-filled formulations, with or without the coupling agent, as a function of time during curing, where the temperature profile (150°C for 60 min) is co-plotted. At the beginning of the heating profile, the contact resistance decreased initially and increased gradually until the end of the thermal cure process. After the cure process, the temperature was lowered to room temperature by natural cooling. At room temperature, the cured Cu-filled ICAs without the coupling agent still showed a very high contact resistance, of around the 100 MΩ range, while the cured Cu-filled ICAs with the coupling agent showed a very low contact resistance of around 0.3 Ω. This improvement may be attributed to the antioxidant role of the coupling agent, and the coupling agent used was effective in obtaining low bulk resistance by protecting the Cu powders from oxidation during thermal cure at 150°C. Thus, we found that the addition of a silane coupling agent to the Cu-filled ICA formulation was effective for the low contact resistance of Cu-filled

Table I. The Combination of Variables used in the Samples for Contact Angle Measurement of Silane Coating Layer on Copper Substrate. Untreated Samples were also Prepared

Silane Solution (%)	Dipping Time (min)	Curing Temperature (°C)
CA 1 & 2, 5%	10	130
CA 1 & 2, 5%	30	130
CA 1 & 2, 5%	50	130
CA 1 & 2, 10%	10	130
CA 1 & 2, 10%	30	130
CA 1 & 2, 10%	50	130

Table II. The Combination of Variables for the Aging Effect on Contact Angle Measurement of Silane Coating Layers on Copper Substrates. Each sample was dipped in the silane solution for 30 min, cured for 30 min, and aged for 10 min

Silane Solution (%)	Curing Temperature (°C)	Aging Temperature (°C)
CA 1 & 2, 5%	130	50
CA 1 & 2, 5%	130	100
CA 1 & 2, 5%	130	150
CA 1 & 2, 5%	130	200
CA 1 & 2, 10%	130	50
CA 1 & 2, 10%	130	100
CA 1 & 2, 10%	130	150
CA 1 & 2, 10%	130	200

Fig. 3. *In situ* measurement of resistance of Cu-filled ICA during thermal cure.

ICA composite during the typical thermal cure condition of ICAs.

Figure 4 shows the SEM cross-sectional view of cured Cu-filled ICA. It shows the bimodal distribution of Cu flakes, and the contacts and interfaces between Cu flakes in the ICA. The intimate contacts between Cu flakes are essential for electrical conduction through the network of the Cu flakes in the ICA materials.

Effect of Concentration of Silane Coupling Agent on Thermal Stability of Copper-Filled ICA

While the silane coupling agent is effective in preventing Cu powder oxidation, there is still concern about the electrical stability of cured Cu-filled ICAs at elevated temperatures, such as a reflow temperature over 250°C. The substrate on which the Cu-filled ICAs are used as either chip bonding or

Fig. 4. Cross-sectional SEM picture of Cu-filled ICA materials.

Fig. 5. Temperature dependence of bulk resistance of Cu-filled ICA composite with different concentrations of silane coupling agent.

via filling can experience the typical reflow processes. Therefore, we monitored the contact resistance of Cu-filled ICAs with the coupling agent between two Cu wire electrodes during a temperature variation from 30°C to 260°C to investigate the thermal stability of the electrical property of Cu-filled ICA joints.

Figure 5 shows the temperature dependency of the contact resistances of Cu-filled ICAs with different concentrations of CA 1. The contact resistance was stable up to 150°C, while it increased slightly at higher temperatures. Cu-filled ICAs with 2, 4, and 6 wt.% CA 1 exhibited ~2,700, 700, and 300% increase in resistance at 260°C, respectively. As the concentrations of the coupling agent increased, the thermal stability of the bulk resistance of copper-filled ICA improved. This result indicates that the addition of optimized amounts of coupling agent is also effective in improving the thermal stability of the electrical property of Cu-filled ICA joints, presumably by protecting further oxidation of copper powder at elevated temperature.

Effect of Type of Coupling Agent on Thermal Stability of Cu-Filled ICAs

The contact resistances of ICA joints should be stable under harsh environmental conditions. Especially, the thermal oxidation at the surfaces of Cu flakes, or at the interfaces between Cu flakes and electrodes, due to elevated temperature from multiple reflow processes may be one of the main failure mechanisms of Cu-filled ICA joints. We evaluated the thermal stability of such joints with different types of coupling agents by measuring contact resistance during multiple reflow processes.

Figure 6 shows the contact resistance of Cu-filled ICAs with different coupling agents with increasing temperature. As the temperature increases, the Cu-filled ICA with 6 wt.% CA 1 showed stable contact resistance up to 200°C, but, after 200°C, contact resistance increased dramatically. On the other hand, the Cu-filled ICA with 6 wt.% CA 2 showed

Fig. 6. Thermal stability of contact resistance of Cu-filled ICA with different silane coupling agents.

lower contact resistance and more stable contact resistance up to 280°C than that with CA 1. This means that CA 2 is more effective in reducing the thermal oxidation of Cu powders in Cu-filled ICAs.

Figure 7 shows the changes in resistance of Cu-filled ICAs with different CAs during triple reflow processes. The Cu-filled ICA with CA 2 was more stable than that with CA 1. This result indicates that CA 2 has superior oxidation-preventing capability than does CA 1 in Cu-filled ICA joints, due to the greater thermal stability of CA 2. The greater thermal stability of CA 2, with its aromatic structure, is related to its higher boiling temperature (T_b), due to its benzene ring and thermally more stable structure than CA 1, with its aliphatic structure. These results also confirm that the CA coating on the surface of copper powder is very effective in preventing the thermal oxidation of copper powders under multiple heat treatment environments.

Fig. 7. Contact resistance behaviors of Cu-filled ICA joints with increasing number of reflow process.

Bulk Resistivity of Cu-Filled ICA Under Harsh Environment

Change in bulk resistivity for Cu-filled ICAs with different CAs was monitored under 85°C/85% relative humidity (RH) and 85°C/dry aging for 24 h, and the results were summarized in Table III.

The Cu-filled ICA with CA 2 showed improved stability, even under the 85°C/85%RH aging test. This may have been due to the thermally stable CA layers and their anti-oxidant capability at elevated temperatures and humidities. Furthermore, the chemical bonding between the CA and the Cu particle surface reduced moisture absorption at the interface. The CA 2 may form a more hydrophobic surface on the Cu particles, and it promotes the reliable contact between Cu powders under conditions of high temperature and humidity.

In order to increase further the electrical conductivity of the Cu-filled ICA, we incorporated bimodal sized Cu flakes. The use of different sized particles yields greater packing density, higher loading and tight contact between particles, providing improved electrical conduction paths in polymers. The bulk resistivity of Cu-filled ICAs with the mono- and bi-modal sized Cu flakes was measured with respect to the filler loadings, as shown in Table IV.

With the bimodal loading of Cu flakes and CA 2, a bulk resistivity of $\sim 10^{-4}$ (Ωcm) was achieved. The enhancement of electrical conductivity by bimodal Cu-filled ECAs is attributed to the decrease in interfacial contact resistance between Cu flakes.

Interaction Between Coupling Agent and Copper Surfaces

The effect of the duration of CA treatment on the contact angle was examined for different types and concentrations of the silane solution, as shown in Fig. 8.

The greater contact angle of the CA-coated surface than that of the neat Cu surface ($\sim 40^\circ$) showed that the CA formed good monolayer coatings on the

Table III. Comparison of Bulk Resistivity and Reliability of Cu-Filled Isotropically Conductive Adhesives with Different Silane Coupling Agent

Sample	Bulk Resistivity (Ωcm)
Cu-filled ICA with CA-1 as cured	1.70×10^{-3}
Cu-filled ICA with CA-2 as cured	1.28×10^{-3}
Cu-filled ICA with CA-1 after 85°C/85%RH for 24 h	Very unstable
Cu-filled ICA with CA-2 after 85°C/85%RH for 24 h	3.00×10^{-3}
Cu-filled ICA with CA-1 after 85°C/dry for 24 h	7.00×10^{-3}
Cu-filled ICA with CA-2 after 85°C/dry for 24 h	1.66×10^{-3}

Table IV. Comparison of Bulk Resistivity of Cu-Filled Isotropically Conductive Adhesives with Different Size Distribution of Filler

Sample	Bulk Resistivity (Ωcm)
Cu-filled ICA with 1–5 μm Cu only, CA-2 as cured	1.28×10^{-3}
Cu-filled ICA with bimodal Cu loading, CA-2 as cured	7.50×10^{-4}

metal surface, as shown in Fig. 9. The metallic Cu surface with basic hydroxyl group, M-OH, shows a low contact angle due to its hydrophilic property, as in Fig. 9a, and the organo-functional silane monolayer on the metallic Cu surface changes the surface chemistry, as in Fig. 9b. The silane monolayer eventually changes the surface energy and hydrophobicity, depending on the organic functional group. The organic functional group (R) of CA 1 is an aliphatic group, and the R of CA 2 is an aromatic

Fig. 9. Surface chemistry schematics of (a) neat Cu surface and (b) organo-functional silane-treated Cu surface.

group. Therefore, the results in Fig. 9 showed a clear difference in contact angles between CA 1 and CA 2. The contact angles of the CA 2 layer ($80\text{--}100^\circ$) were greater than those of the CA 1 layer ($40\text{--}60^\circ$) on the Cu surfaces. This indicated that the CA 2-coated surface had more hydrophobicity than that of CA 1, due to the aromatic functional group, and this hydrophobic coating provided moisture-resistant coatings on a Cu surface. No clear relationships among the concentration of the silane solution, the dipping time and their contact angles were observed.

The effect of aging temperature on the contact angle of the silane coating layer was examined, as shown in Fig. 10. The contact angles of the CA 1-coated Cu surface slightly increased and remained almost constant at about $150\text{--}200^\circ\text{C}$, while those of the CA 2-coated Cu surface decreased slightly but remained over 60° at about $150\text{--}200^\circ\text{C}$, without a rapid decrease. These results indicate that the silane coating layers on Cu are thermally stable up to 200°C , without any degradation or desorption of the silane thin layer. This thermal stability may contribute to the stable contact resistances of the Cu-filled ICA at high temperature ranges.

Overall, CA 2 produced a more hydrophobic surface, which is desirable for low moisture absorption. This finding supports the better performance of Cu-filled ICA with CA 2 over that of CA 1 in the reliability test. This hydrophobic trend was most likely caused by the aromatic groups in CA 2.

CONCLUSION

In order to achieve high performance Cu-filled ICAs, the appropriate surface modification on the Cu flakes is very important if surface oxidation is to be avoided. We demonstrated high performance, low cost, Cu-filled ICAs through the proper selection of the coupling agent and the *in situ* mixing with a matrix resin.

Fig. 8. Results on the contact angles of (a) CA 1-treated samples and (b) CA 2 treated samples and the average contact angle of the freshly cleaned untreated sample with variation in the dipping times.

Fig. 10. The effect of aging temperature on contact angle for the samples of (a) CA 1 and (b) CA 2.

The effect of coupling agents on the prevention of oxidation of Cu metallic fillers for ICA materials, and the electrical and thermal performances and

reliability of Cu-filled ICA joints, were investigated. It was found that the silane coupling agent was very effective in preventing the copper powder oxidation in ICA composite materials, and the improved thermal stability of Cu-filled ICAs was achieved by optimized coupling agents. Bulk resistivity of a Cu-filled ICA with a silane coupling agent was achieved at $1.28 \times 10^{-3} \Omega\text{cm}$.

Better reliability of the Cu-filled ICA joint treated by a coupling agent with aromatic functionality was shown under 85°C/85%RH aging for 24 h than that of the Cu-filled ICA joint treated by a coupling agent with aliphatic functionality. This was mainly due to more hydrophobicity and the high thermal stability of the monolayer of the coupling agent with the aromatic functional group on a copper surface from the contact angle behaviors at room temperature and elevated temperature. By the use of bimodal sized fillers and an optimized concentration of CA 2, low bulk resistivity, $7.5 \times 10^{-4} \Omega\text{cm}$, was obtained.

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